

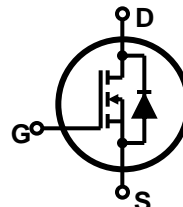
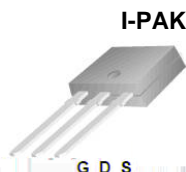
Features

- Low gate charge
- 100% avalanche tested
- Improved dv/dt capability
- RoHS compliant
- Halogen free package
- JEDEC Qualification

$$V_{DSS} = 770 \text{ V @ } T_{jmax}$$

$$I_D = 5 \text{ A}$$

$$R_{DS(on)} = 1.65 \Omega(\text{max}) @ V_{GS} = 10 \text{ V}$$



Device	Package	Marking	Remark
TMD6N70/TMU6N70	D-PAK/I-PAK	TMD6N70/TMU6N70	RoHS
TMD6N70G/TMU6N70G	D-PAK/I-PAK	TMD6N70G/TMU6N70G	Halogen Free

Absolute Maximum Ratings

Parameter	Symbol	TMD6N70(G)/TMU6N70(G)	Unit
Drain-Source Voltage	V_{DSS}	700	V
Gate-Source Voltage	V_{GS}	± 30	V
Continuous Drain Current	I_D	$T_C = 25 \text{ }^\circ\text{C}$	5
		$T_C = 100 \text{ }^\circ\text{C}$	3.14
Pulsed Drain Current (Note 1)	I_{DM}	20	A
Single Pulse Avalanche Energy (Note 2)	E_{AS}	188	mJ
Repetitive Avalanche Current (Note 1)	I_{AR}	5	A
Repetitive Avalanche Energy (Note 1)	E_{AR}	12	mJ
Power Dissipation	P_D	$T_C = 25 \text{ }^\circ\text{C}$	120
		Derate above $25 \text{ }^\circ\text{C}$	0.96
Peak Diode Recovery dv/dt (Note 3)	dv/dt	4.5	V/ns
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55~150	$^\circ\text{C}$
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	T_L	300	$^\circ\text{C}$

* Limited only by maximum junction temperature

Thermal Characteristics

Parameter	Symbol	TMD6N70(G)/TMU6N70(G)	Unit
Maximum Thermal resistance, Junction-to-Case	$R_{\theta JC}$	1.04	$^\circ\text{C}/\text{W}$
Maximum Thermal resistance, Junction-to-Ambient	$R_{\theta JA}$	110	$^\circ\text{C}/\text{W}$

Electrical Characteristics : $T_C=25^\circ\text{C}$, unless otherwise noted

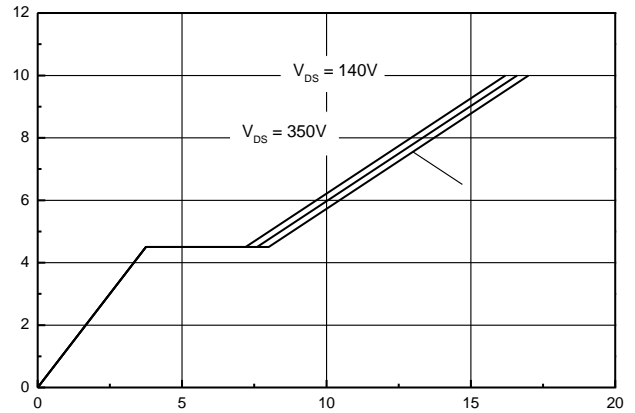
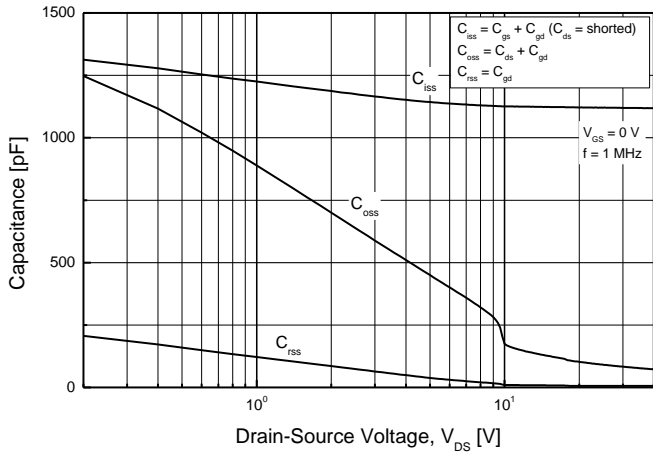
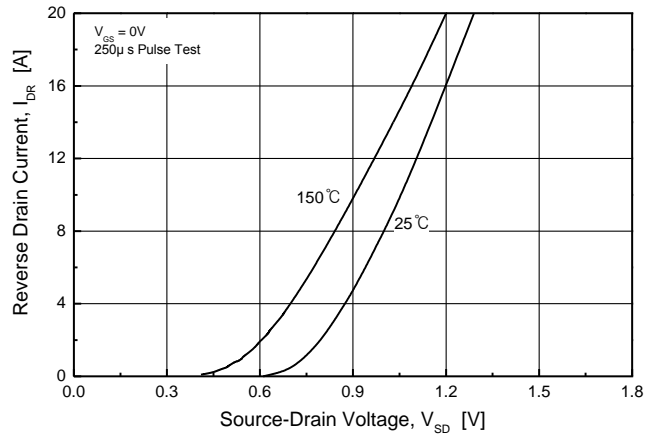
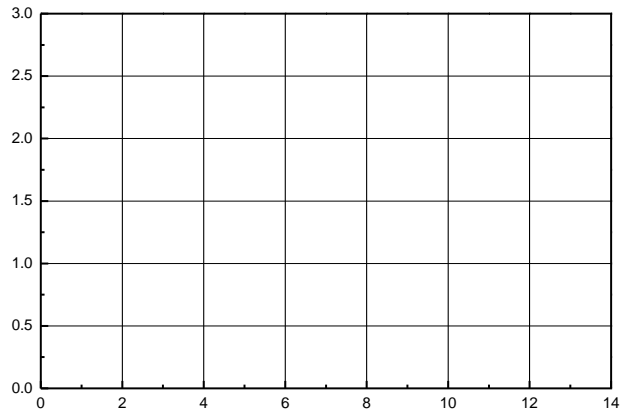
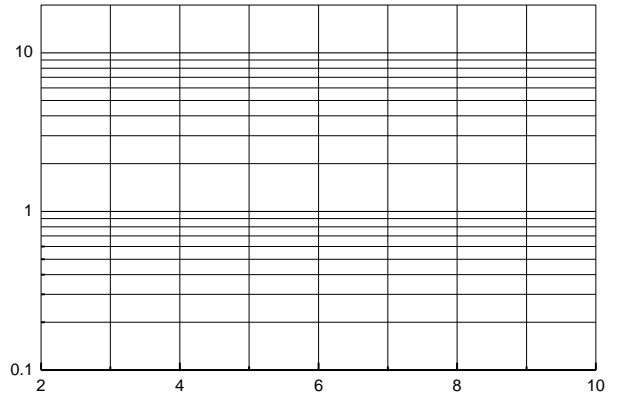
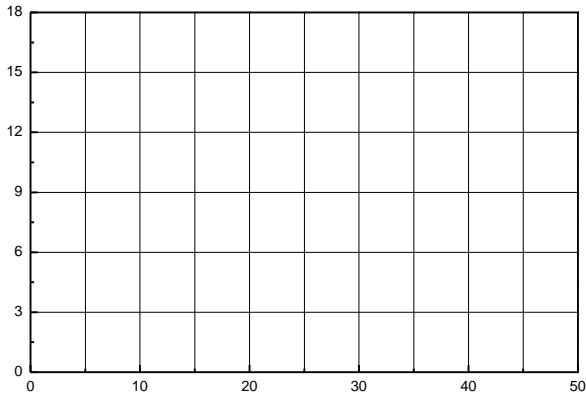
Parameter	Symbol	Test condition	Min	Typ	Max	Units
OFF						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$	700	--	--	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 700\text{ V}, V_{GS} = 0\text{ V}$	--	--	1	μA
		$V_{DS} = 560\text{ V}, T_C = 125^\circ\text{C}$	--	--	10	μA
Forward Gate-Source Leakage Current	I_{GSSF}	$V_{GS} = 30\text{ V}, V_{DS} = 0\text{ V}$	--	--	100	nA
Reverse Gate-Source Leakage Current	I_{GSSR}	$V_{GS} = -30\text{ V}, V_{DS} = 0\text{ V}$	--	--	-100	nA

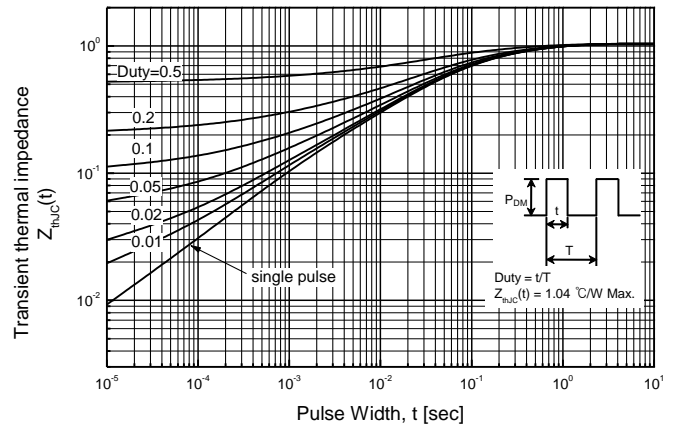
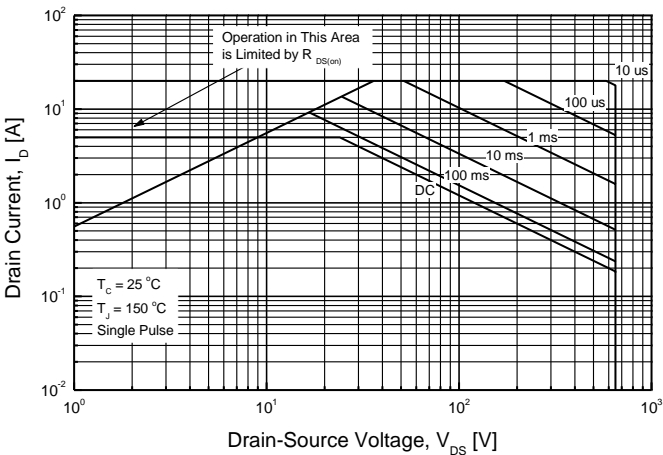
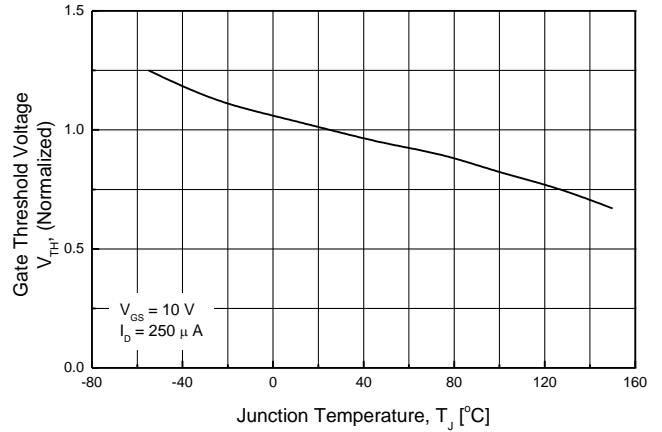
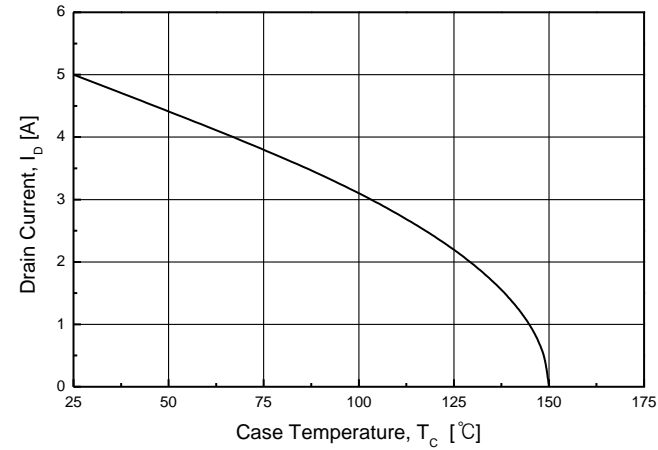
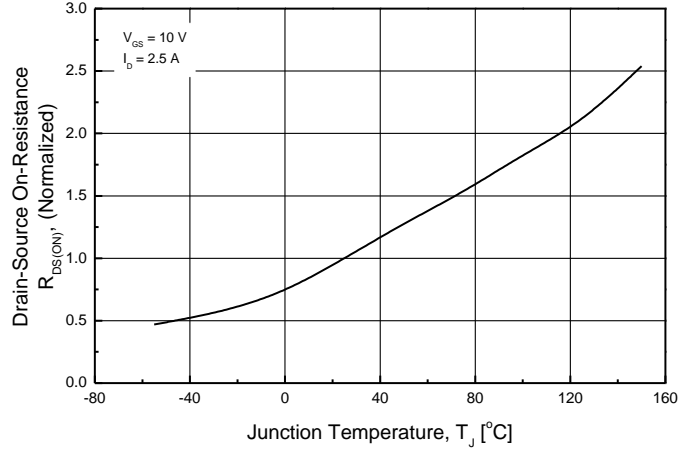
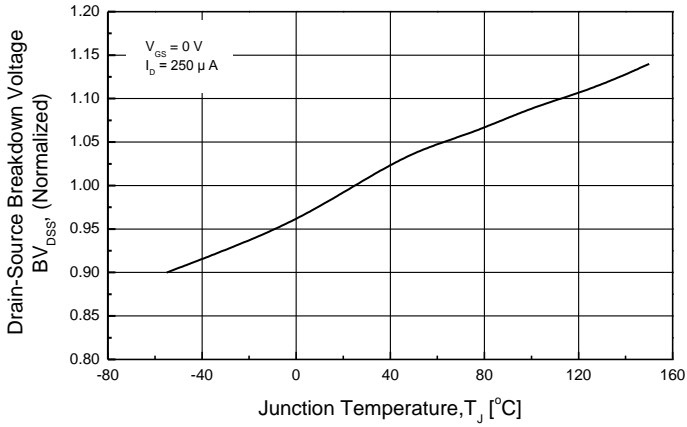
ON						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$	2	--	4	V
Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 2.5\text{ A}$	--	1.42	1.65	Ω
Forward Transconductance ^(Note 4)	g_{FS}	$V_{DS} = 30\text{ V}, I_D = 2.5\text{ A}$	--	7.6	--	S

DYNAMIC						
Input Capacitance	C_{ISS}	$V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V},$ $f = 1.0\text{ MHz}$	--	1120	--	pF
Output Capacitance	C_{OSS}		--	91	--	pF
Reverse Transfer Capacitance _{Resv}	C_{rSS}		--	6.3	--	pF

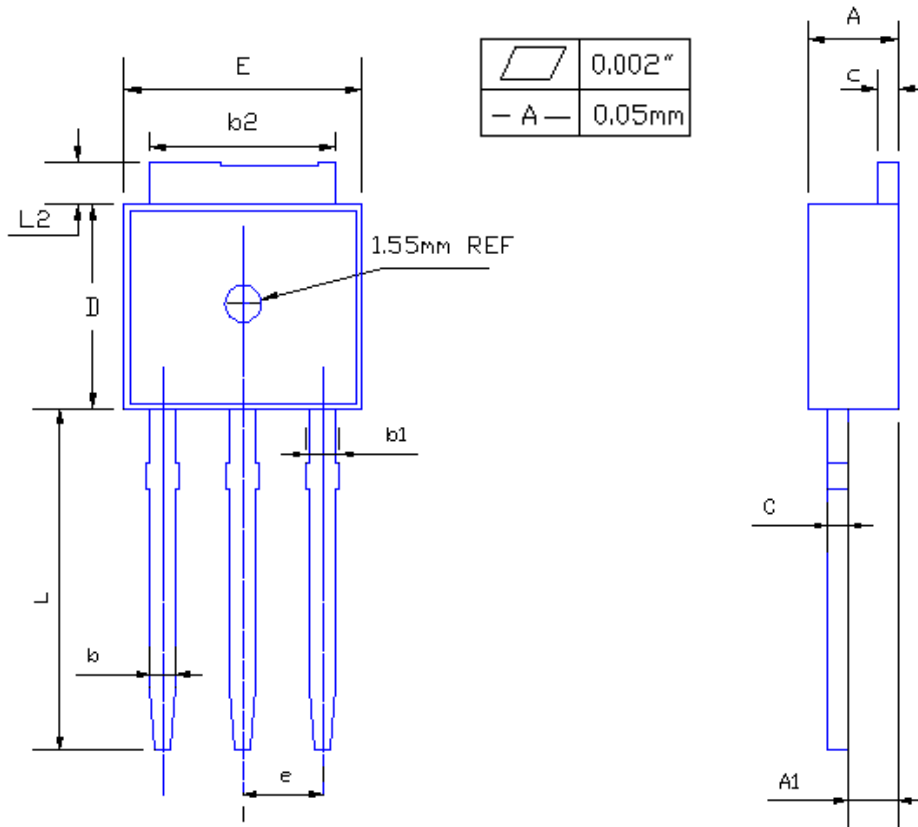
SWITCHING						
Turn-On Delay Time ^(Note 4,5)	$t_{d(on)}$	$V_{DD} = 350\text{ V}, I_D = 5\text{ A},$	$g_{(E)}$	$g_{(EM)}$	$g_{(ES)}$	$g_{(EBC)}$

- Note :
1. Repeated rating : Pulse width limited by safe operating area
 2. $L=14\text{mH}, I_{AS} = 5\text{A}, V_{DD} = 50\text{V}, R_G = 25\Omega,$ Starting $T_J= 25^\circ\text{C}$
 3. $I_{SD} \leq 5\text{A}, di/dt \leq 200\text{A}/\mu\text{s}, V_{DD} \leq BV_{DS},$ Starting $T_J= 25^\circ\text{C}$
 4. Pulse Test :Pulse width $\leq 300\mu\text{s},$ Duty Cycle $\leq 2\%$
 5. Essentially Independent of Operating Temperature Typical Characteristics



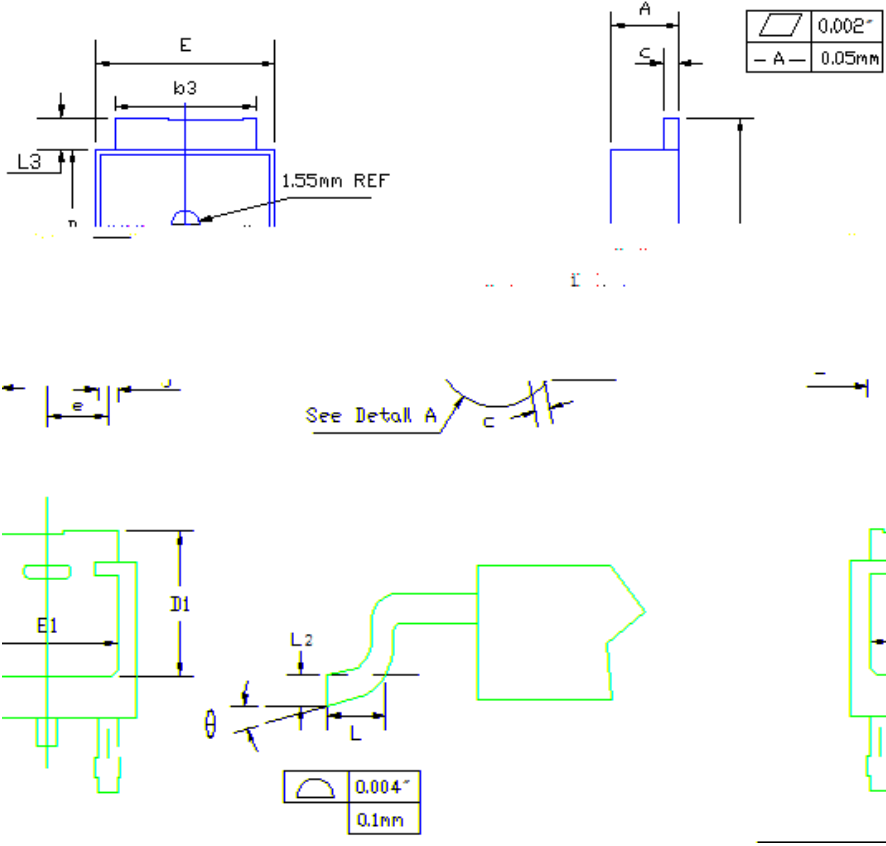


TO-251 (I-PAK) MECHANICAL DATA



SYMBOL	MILLIMETERS	
	MIN	MAX
A	2.19	2.38
A1	1.04	1.23
b	0.64	0.89
b1	0.84	1.14
b2	5.23	5.48
c	0.46	0.61
D	5.91	6.28
E	6.21	6.59
e	2.28 TYP	
L	8.89	9.65
L2	0.89	1.27

TO-252 (D-PAK) MECHANICAL DATA



SYMBOL	MILLIMETERS	
	MIN	MAX
A	2.19	2.38
A1	—	0.13
b	0.64	0.89
b2	0.84	1.14
b3	5.21	5.46
c	0.46	0.61
D	5.97	6.22
D1	5.21	—
E	6.35	6.73
E1	4.83	—
e	2.29BSC	
H	9.65	10.41
L	1.40	1.78
L2	0.51BSC	
L3	0.89	1.27
L4	0.64	1.01
θ	0	8